

Notice of References Cited	Application/Control No. 10/708,879		Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Robert J. Popovics		Art Unit 1724	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,927,547 A	05-1990	Backman, Sune	210/771
*	B	US-4,992,641 A	02-1991	Budin et al.	219/69.14
*	C	US-5,034,121 A	07-1991	Budin et al.	210/108
*	D	US-5,028,319 A	07-1991	Budin et al.	210/134
*	E	US-5,071,567 A	12-1991	Corcelle et al.	210/744
*	F	US-5,177,335 A	01-1993	Hartwig et al.	219/69.14
*	G	US-5,217,605 A	06-1993	Kottke, Gordon V.	210/120
*	H	US-5,298,161 A	03-1994	Sieg, Arno	210/321.78
*	I	US-5,906,737 A	05-1999	Hoepfner, Michael A.	210/232
*	J	US-6,183,653 B1	02-2001	Yoshida, Takeshi	210/770
*	K	US-2003/0178351 A1	09-2003	Doyle et al.	210/131
*	L	US-6,881,330 B2	04-2005	Doyle et al.	210/132
*	M	US-2005/0218089 A1	10-2005	Wei et al.	210/805

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 59160512 A	09-1984	Japan	MIYAHARA et al.	B01D 35/02
*	O	JP 63123639 A	05-1988	Japan	TAKAHASHI et al.	B23H 07/36
*	P	JP 02009534 A	01-1990	Japan	LEVY et al.	B23H 07/36
*	Q	JP 02009533 A	01-1990	Japan	STRICKER, MAX	B23H 07/36
*	R	JP 02076632 A	03-1990	Japan	BUDIN et al.	B23H 07/36
*	S	DE 19920892 A1	11-1999	Germany	YOSHIDA, TAKESHI	B23H 01/10
*	T	WO 2005018777 A1	03-2005	World Intellect	FRAIOLI, SERGE	B01D 41/04

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/708,879	Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Robert J. Popovics	Art Unit 1724	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,551,602 A	11-1985	Inoue et al.	219/69.14
*	B	US-4,584,450 A	04-1986	Inoue, Kiyoshi	219/69.17
*	C	US-4,626,332 A	12-1986	Inoue, Kiyoshi	204/237
*	D	US-4,740,315 A	04-1988	Backman, Sune	210/771
*	E	US-4,859,324 A	08-1989	Levy et al.	210/195.2
*	F	US-4,921,602 A	05-1990	Froderberg et al.	210/232
*	G	US-5,013,432 A	05-1991	Martinez-Mugica, Fernando	210/195.1
*	H	US-5,189,276 A	02-1993	Magara, Takuji	219/69.14
*	I	US-5,434,381 A	07-1995	Mitcheson, George R.	219/69.14
*	J	US-5,714,054 A	02-1998	Frembgen, Fritz-Herbert	205/673
*	K	US-5,935,457 A	08-1999	Kita et al.	219/69.14
*	L	US-6,533,927 B1	03-2003	Hosaka, Akio	210/97
*	M	US-6,683,269 B2	01-2004	Kita et al.	219/69.14

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 59053130 A	03-1984	Japan	MICHISHITA et al.	B23P 01/16
*	O	JP 63123638 A	05-1988	Japan	TAKAHASHI et al.	B23H 07/36
*	P	JP 02076633 A	03-1990	Japan	BUDIN et al.	B23H 07/36
*	Q	JP 02076634 A	03-1990	Japan	BUDIN et al.	B23H 07/36
*	R	JP 2005279924 A	10-2005	Japan	WEI et al.	B23H 07/36
*	S	JP 2005319577 A	11-2005	Japan	LAMPHERE et al.	B23H 01/00
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/708,879		Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner Robert J. Popovics		Art Unit 1724	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,067,358 A	12-1962	DE MAINE FRANK J	219/69.13
*	B	US-3,390,247 A	06-1968	WEBB ROBERT S	219/69.14
*	C	US-3,435,175 A	03-1969	SHAFFER WILLIAM B	219/69.14
*	D	US-3,469,057 A	09-1969	MAINES VIRGIL L	219/69.14
*	E	US-3,678,240 A	07-1972	Dietrick, Gerald P.	219/69.14
*	F	US-4,628,170 A	12-1986	Furukawa, Toshihiko	219/69.14
*	G	US-4,839,488 A	06-1989	Katoh et al.	219/69.14
*	H	US-4,857,688 A	08-1989	Aso et al.	219/69.14
*	I	US-5,464,959 A	11-1995	Takahashi, Nobuyuki	219/69.14
*	J	US-5,798,492 A	08-1998	Enya et al.	219/69.14
*	K	US-2004/0238417 A1	12-2004	Arakawa et al.	210/085
*	L	US-2005/0247569 A1	11-2005	Lamphere et al.	205/663
*	M	US-2006/0108328 A1	05-2006	Luo et al.	219/069.13

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.